Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/691,818	IONEL ET AL.	
Examiner	. Art Unit	
Tamai IE Karl	2834	

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Class	Subclass	Date	Examiner
310	156.55- 156.61, 156.38, 43, 45		
29	598	6/27/2005	KIT
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
h02k001/27.ipc.	6/27/2005	КІТ	
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